S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/900,369	BUCHER, ALAN WEIR
Examiner	Art Unit

Joseph L. Williams

2879

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SEARCHED				
Class	Subclass	Date	Examiner	
313	402-407	10/29/2006	JW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
searche		10/29/2006	JW	

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		DATE	EXMR
None	1	0/29/2006	JW
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